

# Search Notes



Application/Control No.

10/632,467

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under  
Reexamination

WATANABE ET AL.

Art Unit

2187

## SEARCHED

Class	Subclass	Date	Examiner
711	162	7/22/05	Hr
707	204	"	"
714	6	"	"
Updated above using Text search only - see EAST search print out dated - 9/28/05 Hr 9/28/05			

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG Pub Text search - see EAST search printout dated 9/28/05 Hr			

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search his. is attached	7/22/05	Hr
NPL search using terms similar to EAST search	"	"
Inventorship search.	"	"